

# MOSFET - Power, Single N-Channel, SO-8FL 30 V, 52 A NTMFS4C027N

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- CPU Power Delivery
- DC-DC Converters

**MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$  unless otherwise stated)

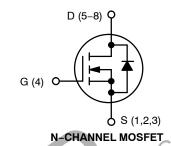
Parar	neter		Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>θJA</sub> (Note 1)		$T_A = 25^{\circ}C$ $T_A = 80^{\circ}C$	Ι <sub>D</sub>	16.4 12.3	Α
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.51	W
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		$T_{A} = 25^{\circ}C$ $T_{A} = 80^{\circ}C$	l <sub>D</sub>	25.3 19.0	NA
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	6.0	¥
Continuous Drain Current $R_{\theta JA}$ (Note 2)	State	$T_A = 25^{\circ}C$ $T_A = 80^{\circ}C$	76	9.0 6.8	A
Power Dissipation R <sub>θJA</sub> (Note 2)	110	T <sub>A</sub> = 25°C	S PD	0:76	W
Continuous Drain Current $R_{\theta JC}$ (Note 1)	1/C	$T_C = 25^{\circ}C$ $T_C = 80^{\circ}C$	S N	52 39	Α
Power Dissipation R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	25.5	W
Pulsed Drain Current	$T_A = 25^\circ$	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	144	Α
Pulsed Source Current (Body Diode)	$T_A = 25^{\circ}$	C, t <sub>p</sub> = 10 μs	I <sub>SM</sub>	560	A
Current Limited by Pac	kage	T <sub>A</sub> = 25°C	I <sub>Dmax</sub>	80	Α
Operating Junction and	Operating Junction and Storage Temperature			-55 to +150	°C
Source Current (Body I	Diode)		I <sub>S</sub>	23	Α
Drain to Source DV/DT			dV/d <sub>t</sub>	7.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy ( $T_J = 25^{\circ}C$ , $V_{GS} = 10$ V, $I_L = 29$ A <sub>pk</sub> , $L = 0.1$ mH, $R_{GS} = 25$ $\Omega$ ) (Note 3)			E <sub>AS</sub>	42	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum rating. Parts are 100% tested at  $T_J=25^{\circ}C$ ,  $V_{GS}=10$  V,  $I_L=21$  Apk,  $E_{AS}=22$  mJ.

1

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
20.1/	4.8 mΩ @ 10 V	E0 A	
30 V	7.47 m $\Omega$ @ 4.5 V	52 A	





#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4C027NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4C027NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.9	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	49.8	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	164.6	*C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{\theta JA}$	21.0	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	$V_{GS}$ = 0 V, $I_{D(aval)}$ = 8.4 A, $T_{case}$ = 25°C, $t_{transient}$ = 100 ns	34		1GN	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>			13.8	٥,	mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 24 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$	JEV	7	1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	in	-1	±100	nA
ON CHARACTERISTICS (Note 6)		0 6	SI	0/	I	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.3		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	IEM JIR OR	4,,	4.9		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 18 A		4.0	4.8	
	<b>U</b> ,c	V <sub>GS</sub> = 4.5 V I <sub>D</sub> = 30 A		6.01	7.47	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A		42		S
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°C	0.3	1.0	2.0	Ω
CHARGES AND CAPACITANCES		7/1/				
Input Capacitance	C <sub>ISS</sub>			1113	1670	
Output Capacitance	Coss	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V		702		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			39		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz		0.035		
Total Gate Charge	Q <sub>G(TOT)</sub>			8.4		
Threshold Gate Charge	Q <sub>G(TH)</sub>			1.8		~0
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$		3.5		nC
Gate-to-Drain Charge	$Q_{GD}$			3.3		
Gate Plateau Voltage	$V_{GP}$			3.4		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A		18.2		nC
SWITCHING CHARACTERISTICS (Note 7)						
Turn-On Delay Time	t <sub>d(ON)</sub>			9.0		
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$		33		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$		15		ns
Fall Time	t <sub>f</sub>			4.0		

- 6. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .
  7. Switching characteristics are independent of operating junction temperatures.

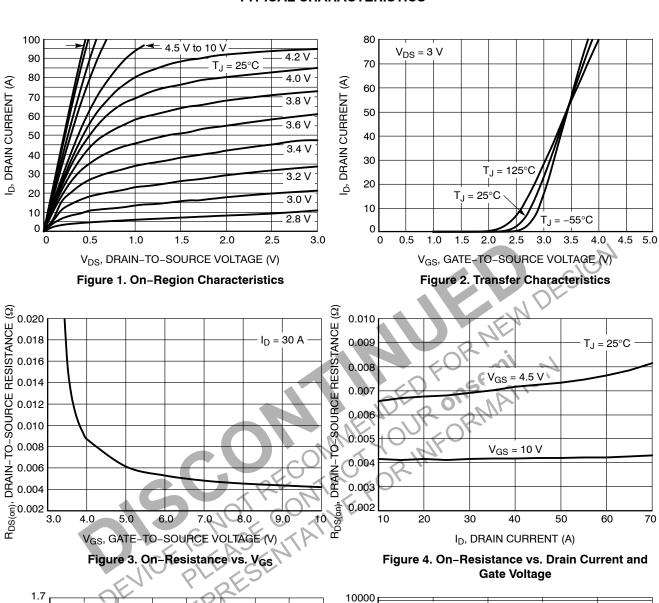
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

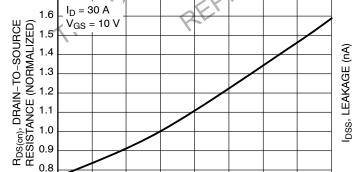
	Symbol	Test Cond	ition	Min	Тур	Max	Unit
WITCHING CHARACTERISTICS (Note 7)	· ·			<u>-</u>	-	<u>-</u>	
urn-On Delay Time	t <sub>d(ON)</sub>				7.0		
ise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			26		ns
urn-Off Delay Time	t <sub>d(OFF)</sub>				19		
all Time	t <sub>f</sub>				3.0		
RAIN-SOURCE DIODE CHARACTERISTIC	cs						
orward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.79	1.1	٧
		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.66		V
everse Recovery Time	t <sub>RR</sub>		•		28.3		
harge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, dIS/dt}$	= 100 A/us,		14.5		ns
ischarge Time	t <sub>b</sub>	$I_S = 30$	Α ΄, ΄, ΄,		13.8	1/2	į
everse Recovery Charge	$Q_{RR}$				15.3	-10,	nC
Switching characteristics are independent of court parametric performance is indicated informance may not be indicated by the Electric performance may not be indicated by the Electric	OREC	ONNE YOU	INFOR				
	$\bigcirc$ $^{\circ}$						

<sup>6.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

<sup>7.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**





0.7 L -50

-25

Figure 5. On–Resistance Variation with Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

50

75

100

125

25

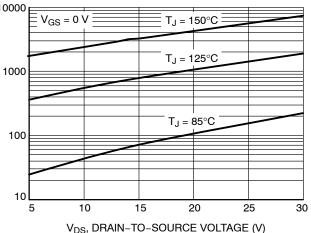


Figure 6. Drain-to-Source Leakage Current vs. Voltage

150

#### **TYPICAL CHARACTERISTICS**

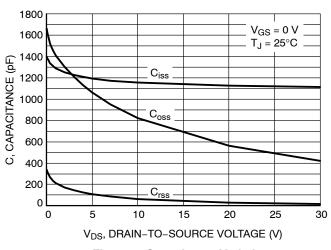


Figure 7. Capacitance Variation

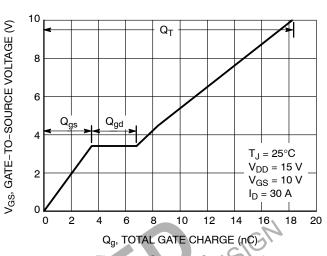


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

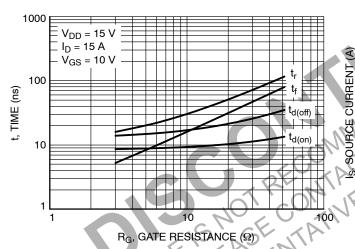


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

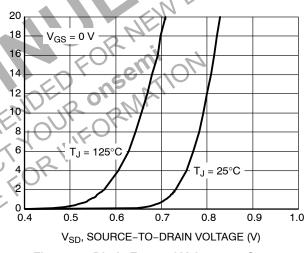


Figure 10. Diode Forward Voltage vs. Current

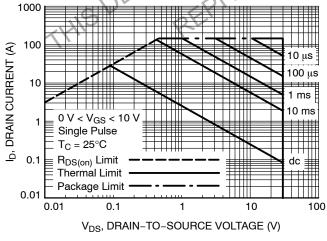


Figure 11. Maximum Rated Forward Biased Safe Operating Area

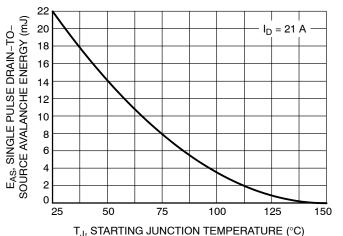
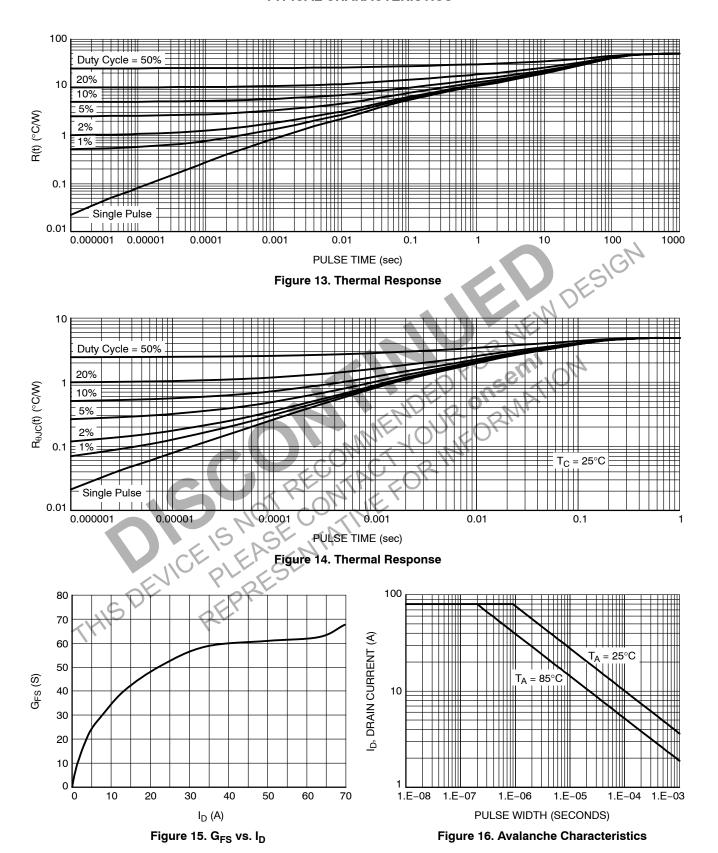


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL CHARACTERISTICS**







DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N** 

## **DATE 25 JUN 2018**

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN NOM MAX				
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	;		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

SIDE VIEW

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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ſ	DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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